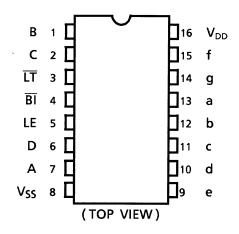
TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

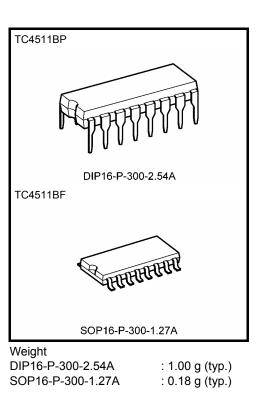
TC4511BP,TC4511BF

TC4511B BCD-to-Seven Segment Latch/Decoder/Driver

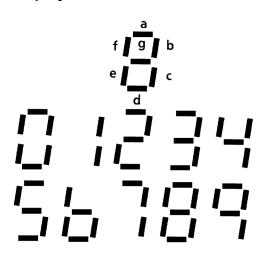
TC4511B is decoder which converts the input of BCD code into the 7 segment display element driving signal and the output has complementary connection of NPN bipolar transistor and N-channel MOS FET. Therefore, not only capability of directly driving cathode common type LED, this has capability of driving various display elements with simple interface circuits. \overline{LT} input and \overline{BI} input are to force all the outputs to be "H" (illuminated) and "L" (not illuminated) respectively regardless of BCD input. As the latch controlled by common LE input is inserted in each of four input lines, static display of dynamic information can be achieved. When an invalid BCD input, "10" or higher is applied, all the outputs become "L" (not illuminated).

Pin Assignment





Display



Truth Table

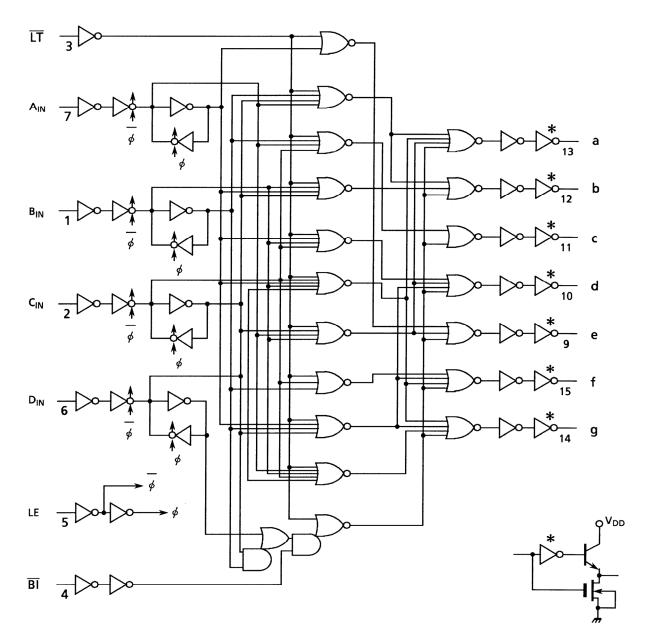
Inputs						Outputs						Display		
LE	BI	LT	D	С	В	А	а	b	С	d	е	f	g	Mode
*	*	L	*	*	*	*	Н	Н	Н	Н	Н	Н	Н	8
*	L	Н	*	*	*	*	L	L	L	L	L	L	L	Blank
L	Н	Н	L	L	L	L	Н	Н	Н	Н	Н	Н	L	0
L	Н	Н	L	L	L	Н	L	Н	Н	L	L	L	L	1
L	Н	Н	L	L	Н	L	Н	Н	L	Н	Н	L	Н	2
L	Н	Н	L	L	Н	Н	Н	Н	Н	Н	L	L	Н	3
L	Н	Н	L	Н	L	L	L	Н	Н	L	L	Н	Н	4
L	Н	Н	L	Н	L	Н	Н	L	Н	Н	L	Н	Н	5
L	Н	Н	L	Н	Н	L	L	L	Н	Н	Н	Н	Н	6
L	Н	Н	L	Н	Н	Н	Н	Н	Н	L	L	L	L	7
L	Н	Н	Н	L	L	L	Н	Н	Н	Н	Н	Н	Н	8
L	Н	Н	Н	L	L	Н	Н	Н	Н	L	L	Н	Н	9
L	Н	Н	Н	L	Н	L	L	L	L	L	L	L	L	Blank
L	Н	Н	Н	L	Н	Н	L	L	L	L	L	L	L	Blank
L	Н	Н	Н	Н	*	*	L	L	L	L	L	L	L	Blank
Н	Н	Н	*	*	*	*				$\Delta\Delta$				

*: Don't care

 $\Delta\!\Delta\!$: Depends upon the BCD code previously applied when LE "L"

TOSHIBA

Logic Diagram



Absolute Maximum Ratings (Note)

Characteristics	Symbol	Rating	Unit
DC supply voltage	V _{DD}	$V_{SS}-0.5V_{SS}+20$	V
Input voltage	V _{IN}	V _{SS} - 0.5~V _{DD} + 0.5	V
Output voltage	Vout	$V_{SS} - 0.5 \text{-} V_{DD} + 0.5$	V
DC input current	l _{IN}	±10	mA
Output high current	I _{ОН}	-50	mA
Power dissipation	PD	300 (DIP)/180 (SOIC)	mW
Operating temperature range	T _{opr}	-40~85	°C
Storage temperature range	T _{stg}	-65~150	°C

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Operating Range (V_{SS} = 0 V) (Note)

Characteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
DC supply voltage	V _{DD}	—	3	_	18	V
Input voltage	V _{IN}	—	0		V _{DD}	V

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V_{DD} or V_{SS} .

Static Electrical Characteristics ($V_{SS} = 0 V$)

		Sym-	Test Condition	-40°C		25°C			85°C			
Charac	teristics	bol		V _{DD} (V)	Min	Max	Min	Тур.	Max	Min	Max	Unit
High-level voltage	output	V _{OH}	$\begin{split} & \left I_{OUT} \right < 1 \; \mu A \\ & V_{IN} = V_{SS}, \; V_{DD} \end{split}$	5 10 15	4.1 9.1 14.1		4.1 9.1 14.1	4.41 9.41 14.41		4.2 9.2 14.2		v
Low-level voltage	output	V _{OL}	$\begin{split} & I_{OUT} < 1 \; \mu A \\ & V_{IN} = V_{SS}, \; V_{DD} \end{split}$	5 10 15		0.05 0.05 0.05		0.00	0.05 0.05 0.05		0.05 0.05 0.05	V
			$I_{OH} = 0 \text{ mA}$ $I_{OH} = 10 \text{ mA}$ $I_{OH} = 20 \text{ mA}$ $V_{IN} = V_{DD}, V_{SS}$	5	4.10 3.90 3.55		4.10 3.90 3.55	4.41 4.25 4.19		4.20 3.90 3.30		
Output hig	jh voltage	V _{OH}	$I_{OH} = 0 \text{ mA}$ $I_{OH} = 10 \text{ mA}$ $I_{OH} = 20 \text{ mA}$ $V_{IN} = V_{DD}, V_{SS}$	10	9.10 9.00 8.70		9.10 9.00 8.70	9.41 9.25 9.20		9.20 9.00 8.40		V
			$I_{OH} = 0 \text{ mA}$ $I_{OH} = 10 \text{ mA}$ $I_{OH} = 20 \text{ mA}$ $V_{IN} = V_{DD}, V_{SS}$	15	14.10 14.00 13.75		14.10 14.00 13.75	14.41 14.26 14.21		14.20 14.00 13.50		
Output lov	v voltage	I _{OL}	$V_{OUT} = 0.4 V$ $V_{OUT} = 0.5 V$ $V_{OUT} = 1.5 V$ $V_{IN} = V_{DD}, V_{SS}$	5 10 15	0.61 1.5 4.0		0.51 1.3 3.4	1.2 3.2 12.0		0.42 1.1 2.8		mA
Input high	voltage	VIH	$\begin{split} V_{OUT} &= 0.5 \text{ V}, 4.5 \text{ V} \\ V_{OUT} &= 1.0 \text{ V}, 9.0 \text{ V} \\ V_{OUT} &= 1.5 \text{ V}, 13.5 \text{ V} \\ & I_{OUT} < 1 \ \mu\text{A} \end{split}$	5 10 15	3.5 7.0 11.0		3.5 7.0 11.0	2.75 5.50 8.25		3.5 7.0 11.0		v
Input low v	voltage	VIL	$\begin{split} V_{OUT} &= 0.5 \text{ V}, 4.5 \text{ V} \\ V_{OUT} &= 1.0 \text{ V}, 9.0 \text{ V} \\ V_{OUT} &= 1.5 \text{ V}, 13.5 \text{ V} \\ & I_{OUT} < 1 \mu A \end{split}$	5 10 15		1.5 3.0 4.0		2.25 4.5 6.75	1.5 3.0 4.0		1.5 3.0 4.0	V
Input current	"H" level "L" level	l _{IH} I _{IL}	V _{IH} = 18 V V _{IL} = 0 V	18 18		0.1 0.1		10 ⁻⁵ -10 ⁻⁵	0.1 -0.1		1.0 -1.0	μA
Quiescent current		I _{DD}	$V_{IN} = V_{SS}, V_{DD}$ (Note)	5 10 15		5 10 20		0.005 0.010 0.015	5 10 20		150 300 600	μΑ

Note: All valid input combinations.

TOSHIBA

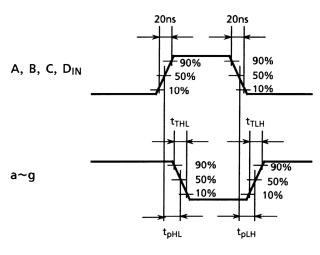
Dynamic Electrical Characteristics (Ta = 25°C, V_{SS} = 0 V, C_L = 50 pF, R_L = 10 k Ω)

Characteristics	Symbol	Test Condition		Min	Тур.	Max	Unit
	Symbol		V _{DD} (V)	IVIIII	i yp.		
Output transition time			5		25	80	
(low to high)	t _{TLH}	—	10	—	15	60	ns
(low to high)			15	_	15	50	
Output transition time			5	_	70	200	
Output transition time	t _{THL}	—	10	—	35	100	ns
(high to low)			15	—	30	80	
			5	_	200	1040	
Propagation delay time	t _{pLH}	—	10	_	90	420	ns
(DATA-OUT)			15	—	65	300	
Description delay firms			5		230	1040	
Propagation delay time	t _{pHL}	—	10	_	110	420	ns
(DATA-OUT)			15	_	80	300	
D			5	_	75	640	
Propagation delay time	t _{pLH}	_	10	_	45	260	ns
(BI -OUT)			15	_	35	200	
			5		90	640	
Propagation delay time	t _{pHL}	_	10	_	50	260	ns
(BI-OUT)			15	_	45	200	
			5	_	60	300	
Propagation delay time	t _{pLH}	_	10	_	40	150	ns
(TT-OUT)	P = 1		15	_	35	100	
			5	_	75	300	
Propagation delay time	t _{pHL}	_	10	_	45	150	ns
(TT-OUT)	P		15	_	35	100	
			5		180	600	
Propagation delay time	t _{pLH}	_	10	_	90	300	ns
(LE-OUT)	P =		15	_	65	250	
			5		230	600	
Propagation delay time	t _{pHL}	_	10		110	300	ns
(LE-OUT)	pric		15	_	85	250	
			5		40	300	
Min pulse time	t _{VVL}	_	10		20	150	ns
(LE)			15		15	120	
			5		35	150	
Min set-up time	tsu	_	10	_	15	70	ns
(DATA-LE)			15	_	10	40	
			5			0	
Min hold time	t _H		10	_	_	0	ns
(DATA-LE)	<u>'п</u>		15		_	0	
Input capacitance	C _{IN}			<u> </u>	5	7.5	pF

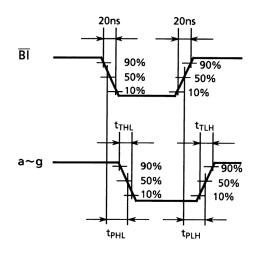
<u>TOSHIBA</u>

Waveform for Measurement of Dynamic Characteristics

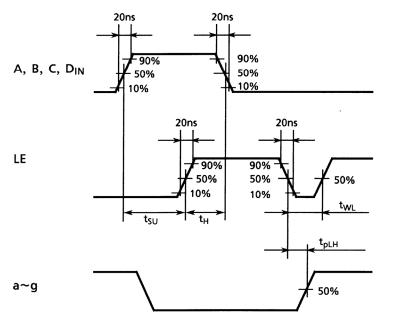
Waveform 1



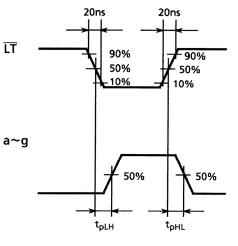
Waveform 2



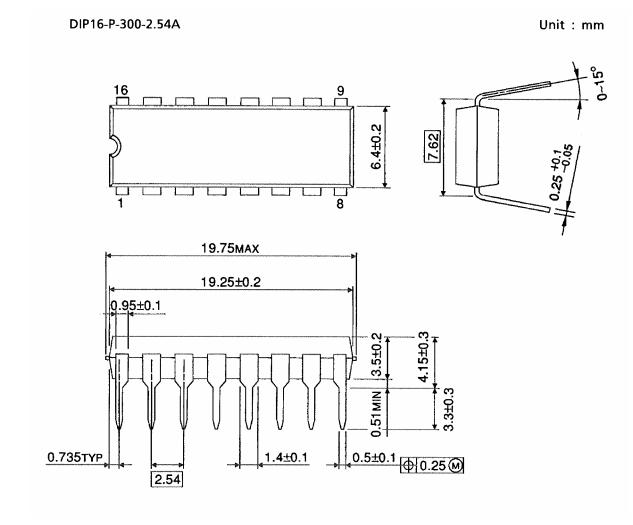
Waveform 3



Waveform 4



Package Dimensions



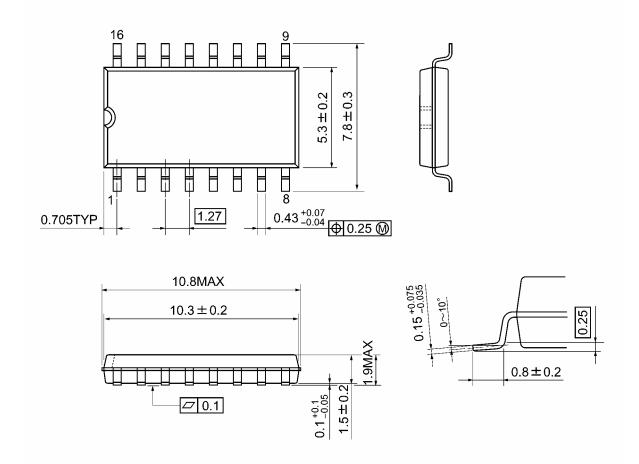
Weight: 1.00 g (typ.)

TOSHIBA

Package Dimensions

SOP16-P-300-1.27A

Unit: mm



Weight: 0.18 g (typ.)

RESTRICTIONS ON PRODUCT USE

20070701-EN GENERAL

- The information contained herein is subject to change without notice.
- TOSHIBA is continually working to improve the quality and reliability of its products. Nevertheless, semiconductor devices in general can malfunction or fail due to their inherent electrical sensitivity and vulnerability to physical stress. It is the responsibility of the buyer, when utilizing TOSHIBA products, to comply with the standards of safety in making a safe design for the entire system, and to avoid situations in which a malfunction or failure of such TOSHIBA products could cause loss of human life, bodily injury or damage to property.
 In developing your designs, please ensure that TOSHIBA products are used within specified operating ranges as set forth in the most recent TOSHIBA products specifications. Also, please keep in mind the precautions and conditions set forth in the "Handling Guide for Semiconductor Devices," or "TOSHIBA Semiconductor Reliability Handbook" etc.
- The TOSHIBA products listed in this document are intended for usage in general electronics applications (computer, personal equipment, office equipment, measuring equipment, industrial robotics, domestic appliances, etc.).These TOSHIBA products are neither intended nor warranted for usage in equipment that requires extraordinarily high quality and/or reliability or a malfunction or failure of which may cause loss of human life or bodily injury ("Unintended Usage"). Unintended Usage include atomic energy control instruments, airplane or spaceship instruments, transportation instruments, traffic signal instruments, combustion control instruments, medical instruments, all types of safety devices, etc.. Unintended Usage of TOSHIBA products listed in his document shall be made at the customer's own risk.
- The products described in this document shall not be used or embedded to any downstream products of which manufacture, use and/or sale are prohibited under any applicable laws and regulations.
- The information contained herein is presented only as a guide for the applications of our products. No
 responsibility is assumed by TOSHIBA for any infringements of patents or other rights of the third parties which
 may result from its use. No license is granted by implication or otherwise under any patents or other rights of
 TOSHIBA or the third parties.
- Please contact your sales representative for product-by-product details in this document regarding RoHS compatibility. Please use these products in this document in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances. Toshiba assumes no liability for damage or losses occurring as a result of noncompliance with applicable laws and regulations.